

# Conference on LED and Its Industrial Application '14

## LEDIA '14

Tuesday, April 22

15:30-15:45 Opening

Room 411, 412

### **Opening Remarks**

15:30 H. Amano, Conference Chair of LEDIA' 14  
Nagoya Univ., Japan

15:45-16:45 LED1: GaN Bulk Growth

Room 411, 412

**Chair: Y. Mori**, Osaka Univ., Japan

**LED1-1 (Invited) Hydride Vapor Phase Epitaxy on Ammonothermally Grown GaN Seeds: Challenges and Perspectives**

M. Boćkowski<sup>1,2)</sup>  
<sup>1)</sup> Institute of High Pressure Physics, PAS,  
Poland, <sup>2)</sup> Top GaN Sp. z o.o., Poland

**LED1-2 16:15 Growth of GaN Layers Using Ga<sub>2</sub>O Vapor Synthesized from Ga Metal**

T. Sumi<sup>1)</sup>, H. Takatsu<sup>1)</sup>, M. Juta<sup>1)</sup>, J. Y. Bu<sup>1)</sup>,  
A. Kitamoto<sup>1)</sup>, M. Imade<sup>1)</sup>, M. Yoshimura<sup>1)</sup>, M.  
Isemura<sup>2)</sup>, and Y. Mori<sup>1)</sup>

<sup>1)</sup> Osaka Univ., Japan, <sup>2)</sup> Itochu Plastics Inc.,  
Japan

**LED1-3 16:30 Controlling the Growth Habit of Early Stage in the Na-Flux Coalescence Growth by the Dipping Technique**

K. Nakamura, M. Imanishi, T. Sato, K.  
Murakami, H. Imabayashi, H. Takazawa, Y.  
Todoroki, D. Matsuo, M. Maruyama, M. Imade,  
M. Yoshimura, and Y. Mori  
Osaka Univ., Japan

16:45-17:30 LED2 : Agricultural Applications

Room 411, 412

**Chair: Y. Mori**, Osaka Univ., Japan

**LED2-1 16:45 (Invited) Present Status of LED-Based Plant Factory in Japan**

M. Takatsuji  
Foundation of Social Development Research  
Center, Japan

**LED2-2 17:15 Far-Red Cr-Doped Garnets for the Control of Photomorphogenesis in Plants Using Phosphor-Conversion LEDs**

A. Zabiliūtė, S. Butkutė, A. Žukauskas, P. Vitta,  
and A. Kareiva  
Vilnius Univ., Lithuania

Wednesday, April 23

9:00-12:00 LED3: UV Devices

Room 411, 412

**Chair: Y. Kumagai, Program Committee Chair,**

Tokyo Univ. of Agri. & Tech., Japan

**LED3-1 9:00 (Invited) Crystal Growth of AlN Single Crystal by Sublimation Method**

S. Nagata  
JFE Mineral Company, Ltd., Japan

**LED3-2**

**9:30**

**(Invited) Recent Progress of AlGaN UVC-LED by Improving Light-Extraction Efficiency**

H. Hirayama  
RIKEN, Japan

**LED3-3**

**10:00**

**Reliability and Lifetime of Pseudomorphic UV-C LED Product for Instrumentation**

M. Toita<sup>1,2)</sup>, J. R. Grandusky<sup>1)</sup>, J. Chen<sup>1)</sup>, K.  
Kitamura<sup>1,2)</sup>, M. C. Mendrick<sup>1)</sup>, C. Moe<sup>1)</sup>, Y. Li<sup>1)</sup>,  
K. Nagase<sup>2)</sup>, T. Morishita<sup>3)</sup>, H. Ishii<sup>3)</sup>, S.  
Yamada<sup>3)</sup>, and L. J. Schowalter<sup>1)</sup>

<sup>1)</sup> Crystal IS, U.S.A., <sup>2)</sup> Asahi Kasei, Japan, <sup>3)</sup>  
Asahi Kasei Microdevices, Japan

**LED3-4**

**10:15**

**Nonpolar M-Plane AlGaN Deep-UV LEDs**

R. G. Banal, Y. Taniyasu, and H. Yamamoto  
NTT Corp., Japan

----- Break (10:30-10:45) -----

**Chair: H. Hirayama**, RIKEN, Japan

**LED3-5**

**10:45**

**Temperature Dependence of Deep Ultraviolet Emission for Diamond Light Emitting Diodes**

D. Kuwabara<sup>1,3)</sup>, T. Makino<sup>2,3)</sup>, D. Takeuchi<sup>2,3)</sup>,  
H. Kato<sup>2,3)</sup>, M. Ogura<sup>2,3)</sup>, H. Okushi<sup>2,3)</sup>, and S.  
Yamasaki<sup>1,3)</sup>

<sup>1)</sup> Univ. of Tsukuba, Japan, <sup>2)</sup> AIST, Japan, <sup>3)</sup>  
CREST, Japan

**LED3-6**

**11:00**

**Investigation of Hole Injection in UV-LEDs Utilizing Polarization Effect**

T. Yasuda<sup>1)</sup>, K. Hayashi<sup>1)</sup>, T. Nakashima<sup>1)</sup>, T.  
Takeuchi<sup>1)</sup>, S. Kamiyama<sup>1)</sup>, M. Iwaya<sup>1)</sup>, I.  
Akasaki<sup>1,2)</sup>, and H. Amano<sup>2,3)</sup>

<sup>1)</sup> Meijo Univ., Japan, <sup>2)</sup> Akasaki Research  
Center, Japan, <sup>3)</sup> Nagoya Univ., Japan

**LED3-7**

**11:15**

**Optimization of InGaN Superluminescent Diodes: State of the Art Devices and an Analysis of their Limiting Factors**

A. Kafar<sup>1)</sup>, S. Stanczyk<sup>1)</sup>, G. Targowski<sup>2,3)</sup>, P.  
Wisniewski<sup>1)</sup>, T. Suski<sup>1)</sup>, U. T. Schwarz<sup>4)</sup>, and P.  
Perlin<sup>1,2)</sup>

<sup>1)</sup> Institute of High Pressure Physics, PAS,  
Poland, <sup>2)</sup> TopGaN Sp. z o.o., Poland, <sup>3)</sup>  
Fraunhofer Institute for Applied Solid State Physics  
IAF, Germany, <sup>4)</sup> Freiburg Univ.,  
Germany

**LED3-8**

**11:30**

**The Impact of Al-Composition on Microstructures and Crystalline Quality of Semi-Polar Al<sub>x</sub>Ga<sub>1-x</sub>N on GaAs Substrates by MOVPE Growth**

P. Saengkaew<sup>1)</sup>, S. Sanorpim<sup>2)</sup>, V. Yordsri<sup>3)</sup>, C.  
Thanachayanont<sup>3)</sup>, and K. Onabe<sup>4)</sup>

<sup>1)</sup> King Mongkut's Univ. of Technology North  
Bangkok, Thailand, <sup>2)</sup> Chulalongkorn Univ.,  
Thailand, <sup>3)</sup> MTEC, Thailand, <sup>4)</sup> The Univ. of  
Tokyo, Japan

**LED3-9**

**11:45**

**Optical Properties of Ga-In-O Polycrystalline Films Fabricated by Molecular Precursor Method**

T. Onuma<sup>1,2)</sup>, T. Yasuno<sup>2)</sup>, S. Takano<sup>2)</sup>, R. Goto<sup>2)</sup>,  
S. Fujioka<sup>2)</sup>, T. Hatakeyama<sup>2)</sup>, H. Hara<sup>2)</sup>, C.  
Mochizuki<sup>2)</sup>, H. Nagai<sup>2)</sup>, T. Yamaguchi<sup>2)</sup>, M.  
Sato<sup>2)</sup>, and T. Honda<sup>2)</sup>

<sup>1)</sup> Tokyo National College of Technology, Japan,  
<sup>2)</sup> Kogakuin Univ., Japan

----- Lunch Break (12:00-13:15) -----

**13:15-18:00 LED4: InGaN Devices** Room 411, 412

**Chair: Y. J. Kim, Program Committee Member,**  
Yonsei Univ., Korea

**LED4-1 13:15 (Invited) InGaN Light-Emitting Diodes on c-Face Sapphire Substrates in Green-Yellow Gap Spectral Region**

S. Saito, R. Hashimoto, J. Hwang, and S. Nunoue  
Toshiba Corp., Japan

**LED4-2 13:45 (Invited) 740-nm InGaN-Based LEDs by MOVPE**

K. Ohkawa  
Tokyo Univ. of Science, Japan

**LED4-3 14:15 Enhancement of Vertical Light Extraction from GaN-Based Blue LEDs Using Moth-Eye Patterned Sapphire Substrate**

M. Ohya<sup>1)</sup>, K. Naniwae<sup>1)</sup>, T. Kondo<sup>1)</sup>, A. Suzuki<sup>1)</sup>, M. Mori<sup>1)</sup>, T. Kitano<sup>1)</sup>, and S. Kamiyama<sup>1,2)</sup>  
<sup>1)</sup> EL-Seed Corp., Japan, <sup>2)</sup> Meijo Univ., Japan

**LED4-4 14:30 Investigation of InGaN Light-Emitting Diodes Prepared on High Aspect Ratio Patterned Sapphire Substrate with Sputtered AlN Nucleation Layer**

L. C. Chang, Y. A. Chen, and C. H. Kuo  
National Chiao Tung Univ., Taiwan

----- Break (14:45-15:00) -----

**Chair: K. Ohkawa, Tokyo Univ. of Science, Japan**

**LED4-5 15:00 Roles of Mg Doping in Nitride Semiconductor-Based Light Emitting Diodes with Two Active Regions**

K. Matsui<sup>1)</sup>, T. Morita<sup>1)</sup>, T. Suzuki<sup>1)</sup>, T. Takeuchi<sup>1)</sup>, S. Kamiyama<sup>1)</sup>, M. Iwaya<sup>1)</sup>, and I. Akasaki<sup>1,2)</sup>

<sup>1)</sup> Meijo Univ., Japan, <sup>2)</sup> Akasaki Research Center, Japan

**LED4-6 15:15 Diffusion Injected Multi-Quantum Well Light Emitting Diode Structure**

L. Riuttanen, P. Kivilahti, H. Nykänen, O. Svensk, S. Suihkonen, J. Oksanen, J. Tulkki, and M. Sopanen  
Aalto Univ., Finland

**LED4-7 15:30 The Improvement of Efficiency Droop and Current Spreading on Nitride-Based LEDs Using Electron Transmission Layer**

J. S. Jheng<sup>1)</sup>, C. K. Wang<sup>1)</sup>, Y. Z. Chiou<sup>1)</sup>, T. K. Lin<sup>2)</sup>, and S. J. Chang<sup>3)</sup>

<sup>1)</sup> Southern Taiwan Univ. of Science and Technology, Taiwan, <sup>2)</sup> Epistar Corp., Taiwan, <sup>3)</sup> National Cheng Kung Univ., Taiwan

**LED4-8 15:45 Growth of High Yield LED Structures on 8" Si(111) Substrates Using High throughput MOCVD Reactors**

B. Krishnan, J. Su, S. M. Lee, G. D. Papasouliotis  
Veeco Instruments Inc., U.S.A.

**LED4-9 16:00 Surface Orientation Dependence of the In-Incorporation of THVPE-Grown InGaN Studied by First Principles and Statistical Thermodynamics**

H. Murakami, Y. Fujimura, R. Togashi, Y.

Kumagai, and A. Koukitu

Tokyo Univ. of Agri. & Tech., Japan

**Realization of p-Type Conduction in Mg-Doped N-Polar (0001) GaN Grown by Metalorganic Vapor Phase Epitaxy**

T. Tanikawa<sup>1,2)</sup>, J. H. Choi<sup>1,2)</sup>, K. Shojiki<sup>1)</sup>, S. Kuboya<sup>1)</sup>, R. Katayama<sup>1,2)</sup>, and T. Matsuoka<sup>1,2)</sup>  
<sup>1)</sup> Tohoku Univ., Japan, <sup>2)</sup> CREST, Japan

----- Break (16:30-16:45) -----

**Chair: K. Naniwae, EL-Seed Corp., Japan**

**LED4-11 16:45 Growth Optimization of Green InGaN Multi-Quantum Well on Bulk GaN Substrate by in situ Monitoring System**

T. Mitsunari<sup>1)</sup>, A. Tamura<sup>1)</sup>, S. Usami<sup>1)</sup>, M. Kushimoto<sup>1)</sup>, K. Yamashita<sup>1)</sup>, Y. Honda<sup>1)</sup>, Y. Lacroix<sup>3)</sup>, and H. Amano<sup>1,2)</sup>

<sup>1)</sup> Nagoya Univ., Japan, <sup>2)</sup> Akasaki Research Center, Japan, <sup>3)</sup> YSystems Ltd., Japan

**Evaluation of the Optical Polarization Properties in Semi-Polar {1122} LEDs**

Y. Okamura, K. Nakao, N. Okada, K. Yamane, and K. Tadatomo  
Yamaguchi Univ., Japan

**LED4-12 17:00 Stress Compensated InGaN/AlGaN Superlattices Coherently Grown on Semipolar (1122) GaN Substrates**

J. Nishinaka, M. Funato, and Y. Kawakami  
Kyoto Univ., Japan

**LED4-13 17:15 Relationship between V-Pit Diameter and Potential Barrier Height in InGaN Based Light-Emitting Diodes**

N. Okada, M. Haziq, K. Yamane, Y. Yamada, and K. Tadatomo  
Yamaguchi Univ., Japan

**LED4-14 17:30 Suppression of Metastable-Phase Inclusion in MOVPE-Grown N-Polar (0001) InGaN/GaN Multiple Quantum Wells**

K. Shojiki<sup>1)</sup>, J. H. Choi<sup>1,2)</sup>, T. Iwabuchi<sup>1)</sup>, N. Usami<sup>3)</sup>, T. Tanikawa<sup>1,2)</sup>, S. Kuboya<sup>1)</sup>, T. Hanada<sup>1,2)</sup>, R. Katayama<sup>1,2)</sup>, and T. Matsuoka<sup>1,2)</sup>

<sup>1)</sup> Tohoku Univ., Japan, <sup>2)</sup> CREST, Japan, <sup>3)</sup> Nagoya Univ., Japan

Thursday, April 24

**9:00-9:45 LED5: White LEDs** Room 411, 412

**Chair: G. Hatakoshi, Program Committee Member,**

Toshiba Corp., Japan

**LED5-1 9:00 (Invited) Sialon Phosphors for Improved White LED**

K. Takahashi<sup>1,2)</sup> and N. Hirosaki<sup>1,2)</sup>

<sup>1)</sup> NIMS, Japan, <sup>2)</sup> SIALON Co., Ltd., Japan

**LED5-2 9:30 High Brightness White LED Prepared by Silicone Layer-by-Layer Coatings with Uniform Distribution of Quantum-Dot-Embedded Silica Nanoparticles**

Y. J. Kim<sup>1)</sup>, H. G. Hong<sup>1)</sup>, H. S. Jung<sup>2)</sup>, H. J. Kim<sup>1)</sup>, M. H. Shin<sup>1)</sup>, H. Kim<sup>2)</sup>, and H. Lee<sup>2)</sup>

<sup>1)</sup> Yonsei Univ., Korea, <sup>2)</sup> Nanosquare Inc., Korea

----- Break (9:45-10:00) -----

**10:00-11:45 LED6: Short Presentations for Poster Session**  
Room 411, 412

**Chair: Y. Honda, Program Committee Member,**  
Nagoya Univ., Japan  
**T. Yamaguchi, Program Committee Member,**  
Kogakuin Univ., Japan  
**H. Murakami, Program Committee Member,**  
Tokyo Univ. of Agri. & Tech., Japan  
**R. Togashi, Program Committee Member,**  
Tokyo Univ. of Agri. & Tech., Japan

----- Lunch Break (11:45-13:15) -----

**13:15-15:15 LED6: Poster Session**      Exhibition Hall D

LEDp6-1	<b>Examination of on the Influence of Boron Flow Rate and Substrate in BGaN Epitaxial Growth</b> K.Ueyama, K. Atsumi, H. Mimura, Y. Inoue, T. Aoki, and T. Nakano Shizuoka Univ., Japan	K. Yamazumi, D. Kim, M. Sekiguchi, and S. Sakai The Univ. of Tokushima, Japan
LEDp6-2	<b>Rapid Growth of GaN Layers Using Ga<sub>2</sub>O Vapor on GaN Substrates Grown by Na-Flux Method</b> H. Takatsu <sup>1)</sup> , M. Juta <sup>1)</sup> , T. Sumi <sup>1)</sup> , Y. Bu <sup>1)</sup> , A. Kitamoto <sup>1)</sup> , M. Imade <sup>1)</sup> , M. Yoshimura <sup>1)</sup> , M. Isemura <sup>2)</sup> , and Y. Mori <sup>1)</sup> <sup>1)</sup> Osaka Univ., Japan, <sup>2)</sup> Itochu Plastics Inc., Japan	InGaN Growth on GaN/Sapphire by Increased-Pressure MOVPE K. Yamashita <sup>1)</sup> , Y. Honda <sup>1)</sup> , and H. Amano <sup>1,2)</sup> <sup>1)</sup> Nagoya Univ., Japan, <sup>2)</sup> Akasaki Research Center, Japan
LEDp6-3	<b>Growth of High Crystallinity Thick GaN Layers Using Ga<sub>2</sub>O Vapor</b> M. Juta <sup>1)</sup> , H. Takatsu <sup>1)</sup> , T. Sumi <sup>1)</sup> , Y. Bu <sup>1)</sup> , A. Kitamoto <sup>1)</sup> , M. Imade <sup>1)</sup> , M. Yoshimura <sup>1)</sup> , M. Isemura <sup>2)</sup> , and Y. Mori <sup>1)</sup> <sup>1)</sup> Osaka Univ., Japan, <sup>2)</sup> Itochu Plastics Inc., Japan	Characterization of Dark Spots on GaInN Films by Using Fluorescence Microscope and Secondary Ion Mass Spectroscopy N. Toyomitsu <sup>1)</sup> , L. Sang <sup>2)</sup> , T. Yamaguchi <sup>1)</sup> , T. Honda <sup>1)</sup> , and M. Sumiya <sup>2)</sup> <sup>1)</sup> Kogakuin Univ., Japan, <sup>2)</sup> NIMS, Japan
LEDp6-4	<b>Growth of Homoepitaxial ZnO Thin Layers by Halide Vapor Phase Epitaxy Using Non-Hydrogenous Sources</b> R. Asakawa <sup>1)</sup> , Y. Isa <sup>1)</sup> , N. Kanzaki <sup>1)</sup> , S. Y. Kang <sup>2)</sup> , A. Hiroe <sup>2)</sup> , R. Togashi <sup>1)</sup> , H. Murakami <sup>1)</sup> , Y. Kashiwagi <sup>2)</sup> , Y. Kumagai <sup>1)</sup> , and A. Koukitu <sup>1)</sup> <sup>1)</sup> Tokyo Univ. of Agri. & Tech., Japan, <sup>2)</sup> Tokyo Electron Ltd., Japan	High Efficiency GaN-Based LEDs Grown by Interruption-Free Epitaxial Lateral Overgrowth on Patterned SiO <sub>2</sub> AlN/Sapphire Template Y. A. Chen, C. H. Kuo, L. C. Chang, and J. P. Wu National Chiao Tung Univ., Taiwan
LEDp6-5	<b>Fabrication of In-Doped ZnO Thin Film by Molecular Precursor Method</b> R. Goto, T. Yasuno, H. Nagai, H. Hara, M. Sato, and T. Honda Kogakuin Univ., Japan	The Evaluation of Optical Characteristic of GaN Double Polarity Selective Area Growth by Using MOVPE K. Kuze, Y. Fujita, H. Mimura, Y. Inoue, and T. Nakano Shizuoka Univ., Japan
LEDp6-6	<b>Thermal Stability of β-Ga<sub>2</sub>O<sub>3</sub> Substrates in Mixed Flows of H<sub>2</sub> and N<sub>2</sub></b> C. Eguchi <sup>1)</sup> , T. Fukizawa <sup>1)</sup> , S. Hanagata <sup>1)</sup> , K. Nomura <sup>1)</sup> , K. Goto <sup>2)</sup> , R. Togashi <sup>1)</sup> , H. Murakami <sup>1)</sup> , A. Kuramata <sup>2)</sup> , Y. Kumagai <sup>1)</sup> , and A. Koukitu <sup>1)</sup> <sup>1)</sup> Tokyo Univ. of Agri. & Tech., Japan, <sup>2)</sup> Tamura Corp. Ltd., Japan	In Situ Wafer Temperature Measurement of Gallium Nitride Grown on Sapphire Using Diffuse Reflectance at Two Wavelengths Y. Lacroix <sup>1)</sup> , K. Yamashita <sup>1)</sup> , V. Robichaud <sup>1)</sup> , Y. Majima <sup>1)</sup> , Y. Honda <sup>2)</sup> , and H. Amano <sup>2)</sup> <sup>1)</sup> YSystems Ltd., Japan, <sup>2)</sup> Nagoya Univ., Japan
LEDp6-7	<b>C-Related p-Type Conduction in AlGaN and AlN</b>	Effect of Pseudo Aluminum Templates in RF-MBE Growth of GaN on 4H-SiC Y. Watanabe, S. Osawa, D. Tajimi, T. Yamaguchi, and T. Honda Kogakuin Univ., Japan
LEDp6-8		Control of Surface Roughness of GaN Seed Crystals by Applying a Dipping Technique to the Na-Flux Method T. Sato, M. Imanishi, K. Nakamura, K. Murakami, H. Imabayashi, H. Takazawa, Y. Todoroki, D. Matsuo, M. Maruyama, M. Imade, M. Yoshimura, and Y. Mori Osaka Univ., Japan
LEDp6-9		The Relationship between Growth Habit and the Behaviors of Dislocations of GaN Crystals in the Na-Flux Coalescence Growth M. Imanishi, K. Murakami, H. Imabayashi, H. Takazawa, Y. Todoroki, D. Matsuo, M. Maruyama, M. Imade, M. Yoshimura, and Y. Mori Osaka Univ., Japan
LEDp6-10		High-Speed InN Growth on Yttria-Stabilized Zirconia (111) Substrates by a Two-Step Precursor Generation HVPE System C. Kojima, R. Togashi, R. Imai, N. Fujita, H. Saito, H. Murakami, Y. Kumagai, and A. Koukitu Tokyo Univ. of Agri. & Tech., Japan
LEDp6-11		Nanoscale Optical Analysis Using Cathodoluminescence Combined with Transmission Electron Microscopy A. Maigne and D. J. Stowe Gatan Inc., U.S.A.
LEDp6-12		
LEDp6-13		
LEDp6-14		
LEDp6-15		
LEDp6-16		
LEDp6-17		

<b>LEDp6-18</b>	<b>RF-MBE Growth of pn-GaN Structure and Fabrication of Blue-Green Homojunction-Type Light Emitting Diode</b> K. Narutani <sup>1)</sup> , T. Yamaguchi <sup>1)</sup> , K. Wang <sup>2)</sup> , T. Araki <sup>2)</sup> , Y. Nanishi <sup>2)</sup> , L. Sang <sup>3)</sup> , M. Sumiya <sup>3)</sup> , S. Fujioka <sup>1)</sup> , T. Onuma <sup>1,4)</sup> , and T. Honda <sup>1)</sup> <sup>1)</sup> Kogakuin Univ., Japan, <sup>2)</sup> Ritsumeikan Univ., Japan, <sup>3)</sup> NIMS, Japan, <sup>4)</sup> Tokyo National College of Technology, Japan	<sup>1)</sup> Meijo Univ., Japan, <sup>2)</sup> Mitsubishi Diamond Industrial, Japan, <sup>3)</sup> EL-Seed Corp., Japan, <sup>4)</sup> Akasaki Research Center, Japan
<b>LEDp6-19</b>	<b>Efficiency Improvement of Nitride-Based Light-Emitting Diode with Physical Vapor Deposition AlN Nucleation Layer</b> J. Lee <sup>1)</sup> , C. H. Yen <sup>1)</sup> , W. C. Lai <sup>1)</sup> , Y. Y. Yang <sup>1)</sup> , C. K. Wang <sup>2)</sup> , and S. J. Chang <sup>1)</sup> <sup>1)</sup> National Cheng Kung Univ., Taiwan, <sup>2)</sup> Southern Taiwan Univ. of Science and Technology, Taiwan	<b>InGaN Flip-Chip Light-Emitting Diodes with Embedded Air Voids Grown on Selective-Area Ar-Implanted AlN/Sapphire Substrate</b> Y. H. Yeh <sup>1)</sup> , J. K. Sheu <sup>1)</sup> , M. L. Lee <sup>2)</sup> , C. J. Chang <sup>2)</sup> , P. C. Chen <sup>1)</sup> , Y. C. Yang <sup>1)</sup> , C. H. Yen <sup>1)</sup> , W. C. Lai <sup>1)</sup> <sup>1)</sup> National Cheng Kung Univ., Taiwan, <sup>2)</sup> Southern Taiwan Univ. of Science and Technology, Taiwan
<b>LEDp6-20</b>	<b>Enhancement in Output Power of Blue Nitride-Based Light Emitting Diodes with an Electron Retarded Layer</b> S. B. Chuang <sup>1)</sup> , C. K. Wang <sup>1)</sup> , Y. Z. Chiou <sup>1)</sup> , C. H. Yen <sup>2)</sup> , W. C. Lai <sup>2)</sup> , and S. J. Chang <sup>2)</sup> <sup>1)</sup> Southern Taiwan Univ. of Science and Technology, Taiwan, <sup>2)</sup> National Cheng Kung Univ., Taiwan	<b>Auto-Split Laser Lift-Off Technique for Vertical-Injection GaN-Based Green Light-Emitting Diodes</b> M. Chen <sup>1)</sup> , L. E. Cai <sup>2)</sup> , J. Y. Zhang <sup>1)</sup> , L. Y. Ying <sup>1)</sup> , and B. P. Zhang <sup>1)</sup> <sup>1)</sup> Xiamen Univ., China, <sup>2)</sup> Xiamen University of Technology, China
<b>LEDp6-21</b>	<b>High Current Density LED Performance on Low Dislocation Density GaN on Sapphire</b> T. Sugiyama <sup>1)</sup> , K. Yamashita <sup>2)</sup> , M. Iwai <sup>1)</sup> , Y. Honda <sup>2)</sup> , T. Yoshino <sup>1)</sup> , and H. Amano <sup>2,3)</sup> <sup>1)</sup> NGK Insulators, Ltd., Japan, <sup>2)</sup> Nagoya Univ., Japan, <sup>3)</sup> Akasaki Research Center, Japan	<b>Light-Emitting Diode Panel Lamps</b> W. S. Cheung, Y. F. Cheung, and H. W. Choi The Univ. of Hong Kong, Hong Kong
<b>LEDp6-22</b>	<b>Fabrication of InGaN Based Light-Emitting Diode Using Freestanding {20 2 1} GaN Substrate</b> Y. Denpo, Y. Mitsui, K. Yamane, N. Okada, and K. Tadatomo Yamaguchi Univ., Japan	<b>Design Optimization of Pattern Structure for Improving Light Extraction Efficiency of Light-Emitting Diodes with Patterned Sapphire Substrate</b> H. Cui and S. H. Park Yeungnam Univ., Korea
<b>LEDp6-23</b>	<b>Nitride-Based Light Emitting Diodes with Buried Tunnel Junctions</b> M. Ino <sup>1)</sup> , Y. Kuwano <sup>1)</sup> , T. Morita <sup>1)</sup> , D. Minamikawa <sup>1)</sup> , T. Takeuchi <sup>1)</sup> , S. Kamiyama <sup>1)</sup> , M. Iwaya <sup>1)</sup> , and I. Akasaki <sup>1,2)</sup> <sup>1)</sup> Meijo Univ., Japan, <sup>2)</sup> Akasaki Research Center, Japan	<b>Numerical Study of the LEDs with Injected Current Modulated by Patterned Contact</b> I. Khmyrova <sup>1)</sup> , N. Watanabe <sup>1)</sup> , Ju. Kholopova <sup>2)</sup> , A. Kovalchuk <sup>2)</sup> , and S. Shapoval <sup>2)</sup> <sup>1)</sup> Univ. of Aizu, Japan, <sup>2)</sup> IMT RAS, Russia
<b>LEDp6-24</b>	<b>Fabrication of Vertical-Type GaN-Based Metal Oxide Semiconductor Light-Emitting Diodes</b> S. Fujioka <sup>1)</sup> , T. Yasuno <sup>1)</sup> , A. Sato <sup>1)</sup> , T. Onuma <sup>1,2)</sup> , H. Nagai <sup>1)</sup> , T. Yamaguchi <sup>1)</sup> , M. Sato <sup>1)</sup> , and T. Honda <sup>1)</sup> <sup>1)</sup> Kogakuin Univ., Japan, <sup>2)</sup> Tokyo National College of Technology, Japan	<b>Phosphor-Converted Light-Emitting Diodes with Advanced Color Rendition Properties</b> A. Zabiliūtė, R. Vaicekauskas, P. Vitta, A. Tuzikas, A. Petruslis, and A. Žukauskas Vilnius Univ., Lithuania
<b>LEDp6-25</b>	<b>Study of High-Reflective Ag-Based Electrode on p-Type GaN</b> S. Kawai <sup>1)</sup> , D. Iida <sup>1)</sup> , M. Iwaya <sup>1)</sup> , T. Takeuchi <sup>1)</sup> , S. Kamiyama <sup>1)</sup> , and I. Akasaki <sup>1,2)</sup> <sup>1)</sup> Meijo Univ., Japan, <sup>2)</sup> Akasaki Research Center, Japan	<b>Control of Thickness and Concentration of Color Converting Film Based on Quantum Dots for White LED with High Luminous Efficiency and CRI</b> H. J. Kim, M. H. Shin, H. G. Hong, and Y. J. Kim Yonsei Univ., Korea
<b>LEDp6-26</b>	<b>Fabrication of Nitride-Based Blue LED with Eliminating Light-Absorptive Laser Scribing Damages</b> S. Hanai <sup>1)</sup> , I. Nakatani <sup>2)</sup> , A. Suzuki <sup>1,3)</sup> , T. Kitano <sup>1,3)</sup> , D. Iida <sup>1)</sup> , T. Kato <sup>1)</sup> , M. Iwaya <sup>1)</sup> , T. Takeuchi <sup>1)</sup> , S. Kamiyama <sup>1)</sup> , and I. Akasaki <sup>1,4)</sup>	<b>----- Break (15:15-15:30) -----</b>
		<b>15:30-16:30 LED7: Special Lectures</b> Room 411, 412
		<b>Chair: M. Boćkowski</b> , Institute of High Pressure Physics, PAS, Poland, Top GaN Sp. z o.o., Poland
	<b>LED7-1</b> <b>15:30</b>	<b>Fundamentals and Integration Technologies for Semiconductor Light-Emitting Devices</b> H. Yonezu (Under negotiation) Toyohashi Univ. of Tech., Japan
	<b>LED7-2</b> <b>16:00</b>	<b>Red and Blue LEDs: Physics and Applications of Visible Light Emitting Diodes</b> G. Hatakoshi Toshiba Corp., Japan
		<b>16:30-16:45 Closing</b> Room 411, 412

**Closing Remarks**

**16:30** Y. Kumagai, Program Committee Chair  
Tokyo Univ. of Agri. & Tech., Japan